

<b>Search Notes</b>  	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10520615	KRIEG ET AL.
	<b>Examiner</b> Jacob, Ajith	<b>Art Unit</b> 2112

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
707	102	01/17/2007	Jacob, Ajith

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
See East Search History	01/17/2007	Jacob, Ajith

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>